IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Marie Angelopoulos, et al. Examiner: Unassigned

Serial No: Unassigned Art Unit: Unassigned

Filed: November 22, 2002 **Docket**: YOR920020093US3 (16343ZY)

For: ATTENUATED EMBEDDED PHASE Date: December 4, 2003

SHIFT PHOTOMASK BLANKS

Commissioner for Patents P.O.Box 1450 Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with 37 C.F.R. §§1.56, 1.97 and 1.98, it is respectfully requested that the following references, which are also listed on the attached form PTO-1449, be made of record in the above-identified patent application.

- 1. U.S. Patent No. 6,395,433, dated May 28, 2002, issued to Smith;
- 2. U.S. Patent No. 6,309,780, dated October 30, 2001, issued to Smith;
- 3. Burn, J. Lin, "The Attenuated Phase-Shifting Mask", Solid State Technology, January 1992, pp. 43-47; and

CERTIFICATE OF MAILING BY "EXPRESS MAIL"

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I hereby certify that this correspondence is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 C.F.R. §1.10 on the date indicated above and is addressed to the Mail Stop New Patent Application, Commissioner of Patents and Trademarks, Alexandria, Virginia 22313-1450.

Dated: December 4, 2003

Steven Fischman

4. Liberman, V. et al., "Materials Issues For Optical Components And Photomasks In 157 NM Lithography", J. Vac. Sci. Technol. B17,

November/December 1999, pp. 3273-3279.

Pursuant to 37 C.F.R. §1.98(d), copies of the references listed on the enclosed Form

PTO-1449 are not provided since they were previously made of record in parent application

Serial No. 10/303,341 filed November 22, 2002. The references were cited in the Information

Disclosure Statement filed concurrently with the application on November 22, 2002 and in the

Information Disclosure Statement filed July 28, 2003 and in the Information Disclosure

Statement filed concurrently with U.S. application No. 10/122,876 on April 12, 2002.

Consideration of this Information Disclosure Statement is respectfully requested, since

the information provided herewith may be material to the examination of the present

application as defined under 37 C.F.R. §1.56. This statement is not intended to represent that

a search has been performed or that no other art than that identified herein exists.

The instant Information Disclosure Statement is being submitted concurrent with the

filing of the present application. Therefore, this filing is made under 37 C.F.R. §1.97(b)(1).

An Information Disclosure Statement filed under 37 C.F.R. §1.97(b)(1) requires neither

certification nor fee.

Respectfully submitted.

Steven Fischman

Registration No. 34,594

Scully, Scott, Murphy & Presser 400 Garden City Plaza Garden City, New York 11530 (516) 7472-4343

SF:gc

Docket Number (Optional) Application Number YOR920020093US3 (16343ZY) Unassigned INFORMATION DISCLOSURE CITATION Applicant(s) (Use several sheets if necessary) Marie Angelopoulos, et al. Filing Date Group Art Unit Herewith Unassigned U.S. PATENT DOCUMENTS *EXAMINER REF DOCUMENT NUMBER FILING DATE DATE NAME CLASS SUBCLASS INITIAL IF APPROPRIATE 6,395,433 05/28/02 Smith 6,309,780 10/30/01 Smith FOREIGN PATENT DOCUMENTS REF Translation DOCUMENT NUMBER DATE COUNTRY CLASS SUBCLASS YES NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Burn, J. Lin, "The Attenuated Phase-Shifting Mask", Solid State Technology, January 1992, pp. 43-47

Liberman, V. et al., "Materials Issues For Optical Components And Photomasks In 157 NM Lithography", J. Vac. Sci. Technol. B17, November/December 1999, pp. 3273-3279

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.